## **Amendments to the Claims**

This listing of claims will replace all prior versions, and listings, of claims in the application:

**Listing of Claims:** 

Claims 1-24. (Cancelled)

25. (Currently Amended) A process for preparing a hemifumarate anhydrate of a compound of formula (I):

characterized by 2-theta angle positions in the powder X-ray diffraction pattern of fog 7.1°, 13.5° and 14.2°, said process comprising treating Crystal form Form C at 20-40°C in a mixed solvent of ethyl acetate and water to obtain Crystal Form E, and stirring the Crystal Form E in a mixed solvent of ethyl acetate and water at less than 20°C to obtain a hemifumarate crystal of a compound of formula (I):

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characterized by 2-theta angle positions in the powder X-ray diffraction pattern of 6.6° and 8.5°, and drying the hemifumarate crystal under reduced pressure to obtain said anhydrate.

wherein Crystal Form E is a hemifumarate hydrate of a compounds formula (I) that has 2-theta angle positions in the powder X-ray diffraction patterns of 5.6° and 10.4° as measured by X-ray diffractometry.

26. (Currently Amended) <u>Crystal Form of a A hemifumarate</u> anhydrate of a compound of formula (I):

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Characterized characterized by 2-theta angle positions in the powder X-ray diffraction pattern of  $7.1^{\circ}$ ,  $\frac{13.15}{13.5^{\circ}}$  and  $14.2^{\circ}$ , which crystal is obtained by the process of claim 25.

27. (Currently Amended) A process for preparing a hemifumarate hydrate of a compound of formula (I):

characterized by 2-theta angle positions in the powder X-ray diffraction pattern of 7.1° and 14.2°, said process comprising stirring Crystal Form E in a mixed solvent of ethyl acetate and water to obtain a hemifumarate crystal of a compound of formula (I):

Characterized characterized by 2-theta angle positions in the powder X-ray diffraction patterns of 6.6° and 8.5°, and drying the hemifumarate crystal under reduced pressure to obtain a hemifumarate anhydrate of a compound of formula (I):

characterized by 2-theta angle positions in the powder X-ray diffraction pattern of 7.1°, 13.5° and 14.2°, and conditioning the anhydrate to obtain said hydrate;

wherein <u>crystal Crystal Form E is a hemifumarate hydrate of a compound of formula (I) that contains tetrahydrofuran and that has 2-theta angle positions in the powder X-ray diffraction pattern of 5.6° and 10.4° as measured X-ray diffractometry.</u>

28. (Currently Amended) A <u>Crystal Form of a hemifumarate</u> hydrate of a compound of formula (I):

characterized by 2-theta angle positions in the powder X-ray diffraction pattern of 7.1° and 14.2°, which crystal is obtained by the process of claim 27.

## Claims 29-34. (Cancelled)

35. (Currently Amended) Crystal form Form D of a hemifumarate hydrate of a compound of formula (I):

which crystal is obtained via Crystal Form E,

wherein Crystal Form E is a hemifumarate hydrate of a compound of formula (I) that has 2-theta angle positions in the powder X-ray diffraction pattern of 5.6° and 10.4° as measured X-ray diffractometry.

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